

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination
		10/605,649	CHIEN ET AL.
Examiner	Douglas Q. Tran	Art Unit	2625

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,045,931	09-1991	Sakamoto, Takashi	358/534
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Loce et al. (US Pub.No. 2003/0090729 A1) 5/2003
*	V	Yamada (U.S. Pub. No. 2002/0051209 A1) 5/2002
*	W	Obata (U.S. Pub. No. 2001/0050776 A1) 12/2001
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.